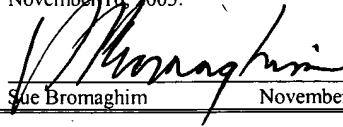


Certificate of Mailing Under 37 CFR 1.8

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Sue Bromaghin

November 16, 2005



**CUSTOMER NO. 36257**

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicants: Mehdi VAEZ-IRAVANI et al.

Title: Sample Inspection System

Application No.: 10/627,402

Filing Date: July 24, 2003

Examiner: Hoa Q. PHAM

Group Art Unit: 2877

Docket No.: TNCR.152US7

Conf. No.: 2861

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Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

**SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT**

Sir:

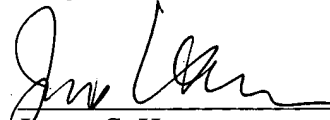
Pursuant to 37 C.F.R. §§ 1.56, 1.97 and 1.98, Applicant(s) call(s) the documents listed on the enclosed Form PTO-1449 to the Examiner's attention in this patent application. ~

- ☒ According to 37 C.F.R. 1.98(2)(ii), copies of the U.S. Patents and U.S. Published Patent Applications documents are not required and are therefore not enclosed. Copies of the listed foreign patent documents or Other Art are enclosed.

Citation of these documents shall not be construed as (1) an admission that the documents are prior art with respect to the invention or inventions claimed in this application, (2) a representation that a search has been made (other than as indicated by any cited document), or (3) an admission that the cited information is, or is considered to be, material to patentability as defined in § 1.56(b).

This information disclosure statement is submitted under 37 C.F.R. § 1.97(b) and consequently no fee should be required. The Commissioner is authorized, however, to charge any fee that may be required, or to credit any overpayment, against Deposit Account No. 502664.

Respectfully submitted,



James S. Hsue  
Reg. No. 29,545

November 16, 2005

Date

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(415) 693-0194 (fax)

U.S. Department of Commerce, Patent and Trademark	Atty. Docket No.	Application No.
INFORMATION DISCLOSURE STATEMENT BY APPLICANT	TNCR.152US7	10/627,402
	Applicant(s)	Conf. No.
(Use several sheets if necessary)	Mehdi VAEZ-IRAVANI et al.	2861
(Form PTO-1449)	Filing Date	Art Group
	July 24, 2003	2877

## U.S. Patent Documents

*Examiner Initial		Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate
	1	4,360,275	11-1982	Louderback			
	2	4,378,159	03-1983	Galbraith			
	3	4,893,032	01-1990	Braden			
	4	5,608,526	03-1997	Piwonka-Corle et al.			
	5	6,292,259 B1	09-2001	Fossey et al.			
	6	6,657,714 B2	12-2003	Almogly et al.			

## Foreign Patent Documents

							Translation	
		Document	Date	Country	Class	Subclass	Yes	No
	7	JP 57-13340	01-1982	JAPAN			full	
	8	JP 63-140904	06-1988	JAPAN			abstract	
	9	JP 63-285449	11-1988	JAPAN			abstract	

## OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

	10	"Integrating Sphere Theory," Laser Beam Measurement, Melles Griot, printed 8/6/2004, pp. 1-5.
	11	"Integrating Sphere," Glossary, The Practical Application of Light, Melles Griot, printed 8/6/2004, 1 page.
	12	"Bespoke Integrating Spheres Now Off-the-Shelf," Laboratorytalk, Product News, Pro-Lite Technology, 14 May 2004, 2 pages.
	13	"Integrating Sphere Fabrication and Coating," Labsphere, Applications, printed 8/6/2004, 1 page.
	14	"A Guide to Reflectance Coatings and Materials," Techguide, Labsphere, 8 pages.
	15	"Integrating Spheres," Spectral Products, 2003, 2 pages.

Examiner

Date Considered

\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with your communication to applicant.

U.S. Department of Commerce, Patent and Trademark				Atty. Docket No.		NOV 18 2005		Application No.	
INFORMATION DISCLOSURE STATEMENT BY APPLICANT				TNCR.152US7				10/627,402	
				Applicant(s)				Conf. No.	
(Use several sheets if necessary)				Mehdi VAEZ-IRAVANI et al.				2861	
(Form PTO-1449)				Filing Date				Art Group	
				July 24, 2003				2877	
<b>U.S. Patent Documents</b>									
*Examiner Initial		Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate		
<b>Foreign Patent Documents</b>									
								Translation	
		Document	Date	Country	Class	Subclass	Yes	No	
	16	EP 1 023 582 B1	11-2003	EUROPE			X		
	17	EP 1 265 063 B1	01-2005	EUROPE			X		
<b>OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)</b>									
	18	Knollenberg, "The Importance of Media Refractive Index in Evaluating Liquid and Surface Microcontamination Measurements," Particle Measuring Systems, Boulder CO, Mar/Apr 1987, 9 pages.							
	19	Wagner et al., "Requirements for Future Surface Inspection Equipments for Bare Silicon Surfaces", Wacker-Chemitronic GmbH, Burghausen, Germany, 8 pages.							
	20	Notification of Transmittal of International Preliminary Examination Report, dated 01 Feb 2000, issued in corresponding PCT/US98/19564, 5 pages.							
	21	Written Opinion, dated 31 Aug 1999, issued in corresponding PCT/US98/19564, 5 pages.							
	22	Communication issued in corresponding EP Application No. 04024371.9, dated March 30, 2005, transmitting the European Search Report, 5 pages.							
Examiner			Date Considered						
<b>*EXAMINER:</b> Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with your communication to applicant.									